

## Chip Multilayer Ceramic Capacitors for Consumer Electronics & Industrial Equipment

### ■ Scope

This specification is applied to Chip Multilayer Ceramic Capacitors.

#### 1. Specific applications:

- Consumer Equipment: Products that can be used in consumer equipment such as home appliances, audio/visual equipment, communication equipment, information equipment, office equipment, and household robotics, and whose functions are not directly related to the protection of human life and property.
- Industrial Equipment: Products that can be used in industrial equipment such as base stations, manufacturing equipment, industrial robotics equipment, and measurement equipment, and whose functions do not directly relate to the protection of human life and property.
- Medial Equipment [GHTF A/B/C] except for Implant Equipment: Products suitable for use in medical devices designated under the GHTF international classifications as Class A or Class B (the functions of which are not directly involved in protection of human life or property) or in medical devices other than implants designated under the GHTF international classifications as Class C (the malfunctioning of which is considered to pose a comparatively high risk to the human body).
- Automotive Infotainment/Comfort Equipment: Products that can be used for automotive equipment such as car navigation systems and car audio systems that do not directly relate to human life and whose structure, equipment, and performance are not specifically required by law to meet technical standards for safety assurance or environmental protection.

#### \*Only for Mobile devices

These MLCC products are designed for use in devices with a typical lifetime of less than 5 years.

(Examples: Cellular phone, Smartphone, Tablet PC, Digital camera, Watch, Electronics dictionary, Small-scale server, IPC-9592B class1 equipment, etc.)

#### 2. Unsuitable Application: Applications listed in "Limitation of applications" in this specification.

WE DISCLAIM ANY LOSS AND DAMAGES ARISING FROM OR IN CONNECTION WITH THE PRODUCTS INCLUDING BUT NOT LIMITED TO THE CASE SUCH LOSS AND DAMAGES CAUSED BY THE UNEXPECTED ACCIDENT, IN EVENT THAT THE PRODUCT IS APPLIED FOR THE PURPOSE WHICH IS SPECIFIED ABOVE AS THE UNSUITABLE APPLICATION FOR THE PRODUCT.



## ■ Specifications and Test Methods

| No   | Item   | Specification   | Test Method(Ref. Standard:JIS C 5101 (all parts), IEC60384 (all parts))   |      |                 |   |                      |   |                           |     |                      |   |                           |   |                      |
|------|--|---|---|------|-----------------|---|----------------------|---|---------------------------|-----|----------------------|---|---------------------------|---|----------------------|
| 1    | Rated Voltage                                  | Shown in Rated value.   | The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor. When AC voltage is superimposed on DC voltage, V(peak to peak) or V(zero to peak), whichever is larger, should be maintained within the rated voltage range.  |      |                 |   |                      |   |                           |     |                      |   |                           |   |                      |
| 2    | Appearance                                     | No defects or abnormalities.  | Visual inspection   |      |                 |   |                      |   |                           |     |                      |   |                           |   |                      |
| 3    | Dimension                                      | Shown in Dimension.   | Using Measuring instrument of dimension.  |      |                 |   |                      |   |                           |     |                      |   |                           |   |                      |
| 4    | Voltage proof                                  | No defects or abnormalities.  | Measurement Point Between the terminations<br>Test Voltage 300% of the rated voltage<br>Applied Time 1s to 5s<br>Charge/discharge current 50mA max.   |      |                 |   |                      |   |                           |     |                      |   |                           |   |                      |
| 5    | Insulation Resistance(I.R.) (Room Temperature) | More than 10000MΩ   | Measurement Temperature Room Temperature<br>Measurement Point Between the terminations<br>Measurement Voltage Rated Voltage<br>Charging Time 2min<br>Charge/discharge current 50mA max.   |      |                 |   |                      |   |                           |     |                      |   |                           |   |                      |
| 6    | Capacitance                                    | Shown in Rated value.   | Measurement Temperature Room Temperature<br>Measurement Frequency 1.0+/-0.1MHz<br>Measurement Voltage 0.5 to 5.0Vrms  |      |                 |   |                      |   |                           |     |                      |   |                           |   |                      |
| 7    | Q or Dissipation Factor (D.F.)                 | $Q \geq 400+20C$ C:Nominal Capacitance(pF)  | Measurement Temperature Room Temperature<br>Measurement Frequency 1.0+/-0.1MHz<br>Measurement Voltage 0.5 to 5.0Vrms  |      |                 |   |                      |   |                           |     |                      |   |                           |   |                      |
| 8    | Temperature Characteristics of Capacitance     | No bias<br><br>Nominal values of the temperature coefficient is shown in Rated value. But, the Capacitance Change under Reference Temperature is shown in Table A.<br>Capacitance Drift: Within +/-0.2% or +/-0.05pF (Whichever is larger.) | The capacitance change should be measured after 5 min at each specified temp. stage.<br>Capacitance value as a reference is the value in "*" marked step.<br>Capacitance Drift The capacitance drift is calculated by dividing the differences between the maximum and minimum measured values in the step 1,3 and 5 by the cap. value in step 3.<br>Measurement Voltage Less than 1.0Vrms (Refer to the individual data sheet)<br>Temperature Step<br><br>< No bias ><br><table border="1"> <thead> <tr> <th>Step</th> <th>Temperature(°C)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>Reference Temp. +/-2</td> </tr> <tr> <td>2</td> <td>Min. Operating Temp. +/-3</td> </tr> <tr> <td>3 *</td> <td>Reference Temp. +/-2</td> </tr> <tr> <td>4</td> <td>Max. Operating Temp. +/-3</td> </tr> <tr> <td>5</td> <td>Reference Temp. +/-2</td> </tr> </tbody> </table> | Step | Temperature(°C) | 1 | Reference Temp. +/-2 | 2 | Min. Operating Temp. +/-3 | 3 * | Reference Temp. +/-2 | 4 | Max. Operating Temp. +/-3 | 5 | Reference Temp. +/-2 |
| Step | Temperature(°C)                                |   |   |      |                 |   |                      |   |                           |     |                      |   |                           |   |                      |
| 1    | Reference Temp. +/-2                           |   |   |      |                 |   |                      |   |                           |     |                      |   |                           |   |                      |
| 2    | Min. Operating Temp. +/-3                      |   |   |      |                 |   |                      |   |                           |     |                      |   |                           |   |                      |
| 3 *  | Reference Temp. +/-2                           |   |   |      |                 |   |                      |   |                           |     |                      |   |                           |   |                      |
| 4    | Max. Operating Temp. +/-3                      |   |   |      |                 |   |                      |   |                           |     |                      |   |                           |   |                      |
| 5    | Reference Temp. +/-2                           |   |   |      |                 |   |                      |   |                           |     |                      |   |                           |   |                      |
| 9    | Adhesive Strength of Termination               | No removal of the terminations.   | Mounting method Solder the capacitor on the test substrate<br>Applied Force 5N<br>Holding Time 10+/-1s<br>Applied Direction In parallel with the test substrate and vertical with the capacitor side  |      |                 |   |                      |   |                           |     |                      |   |                           |   |                      |

**Specifications and Test Methods**

| No   | Item                                    | Specification  |  | Test Method(Ref. Standard:JIS C 5101 (all parts), IEC60384 (all parts))   |   |      |            |           |   |                          |        |   |            |        |   |                          |        |   |            |        |
|------|---|--|--|---|---|------|------------|-----------|---|--------------------------|--------|---|------------|--------|---|--------------------------|--------|---|------------|--------|
| 10   | Vibration                               | Appearance<br>Capacitance<br>Q or D.F.                                 | No defects or abnormalities.<br>Within the specified initial value.<br>Within the specified initial value.   | Mounting method<br>Kind of Vibration<br>Vibration Time<br>Total amplitude<br>Vibration directions and time                      | Solder the capacitor on the test substrate<br>A simple harmonic motion 10Hz to 55Hz to 10Hz<br>1min<br>1.5mm<br>This motion should be applied for a period of 2hours in each 3 mutually perpendicular directions(total of 6hours).  |      |            |           |   |                          |        |   |            |        |   |                          |        |   |            |        |
| 11   | Substrate Bending test                  | Appearance<br>Capacitance Change                                       | No defects or abnormalities.<br>Within +/-0.5pF  | Mounting method<br>Pressurization Method<br>Flexure<br>Holding Time   | Reflow solder the capacitor on the test substrate<br>Shown in Fig.2<br>1mm<br>5+/-1s  |      |            |           |   |                          |        |   |            |        |   |                          |        |   |            |        |
| 12   | Solderability                           | 95% of the terminations is to be soldered evenly and continuously.     |  | Test Method<br>Flux<br>Preheat<br>Kind of Solder<br>Test Temperature<br>Test Time   | Solder bath method<br>Solution of rosin ethanol 25(mass)%<br>80°C to 120°C、 10s to 30s<br>Sn-3.0Ag-0.5Cu(Lead Free Solder)<br>245+/-5°C<br>2+/-0.5s   |      |            |           |   |                          |        |   |            |        |   |                          |        |   |            |        |
| 13   | Resistance to Soldering Heat            | Appearance<br>Capacitance Change<br>Q or D.F.<br>I.R.<br>Voltage proof | No defects or abnormalities.<br>Within +/-0.25pF<br>Within the specified initial value.<br>Within the specified initial value.<br>No defects or abnormalities. | Test Method<br>Kind of Solder<br>Test Temperature<br>Test Time<br>Preheat Temperature<br>Preheat time<br>Post-treatment         | Solder bath method<br>Sn-3.0Ag-0.5Cu(Lead Free Solder)<br>270+/-5°C<br>10+/-0.5s<br>120°C to 150°C<br>1 min<br>Non treatment:Let sit for 24+/-2hours at room temperature, then measure.   |      |            |           |   |                          |        |   |            |        |   |                          |        |   |            |        |
| 14   | Temperature Sudden Change               | Appearance<br>Capacitance Change<br>Q or D.F.<br>I.R.<br>Voltage proof | No defects or abnormalities.<br>Within +/-0.25pF<br>Within the specified initial value.<br>Within the specified initial value.<br>No defects or abnormalities. | Mounting method<br>Cycles<br>Temperature Cycling<br><br><br><br>Post-treatment  | Solder the capacitor on the test substrate<br>5cycles<br><br><table border="1" style="margin-left: auto; margin-right: auto;"><thead><tr><th>Step</th><th>Temp. (°C)</th><th>Time(min)</th></tr></thead><tbody><tr><td>1</td><td>Min.Operating Temp.+0/-3</td><td>30+/-3</td></tr><tr><td>2</td><td>Room Temp.</td><td>2 to 3</td></tr><tr><td>3</td><td>Max.Operating Temp.+3/-0</td><td>30+/-3</td></tr><tr><td>4</td><td>Room Temp.</td><td>2 to 3</td></tr></tbody></table><br>Non treatment:Let sit for 24+/-2hours at room temperature, then measure. | Step | Temp. (°C) | Time(min) | 1 | Min.Operating Temp.+0/-3 | 30+/-3 | 2 | Room Temp. | 2 to 3 | 3 | Max.Operating Temp.+3/-0 | 30+/-3 | 4 | Room Temp. | 2 to 3 |
| Step | Temp. (°C)                              | Time(min)  |  |   |   |      |            |           |   |                          |        |   |            |        |   |                          |        |   |            |        |
| 1    | Min.Operating Temp.+0/-3                | 30+/-3   |  |   |   |      |            |           |   |                          |        |   |            |        |   |                          |        |   |            |        |
| 2    | Room Temp.                              | 2 to 3   |  |   |   |      |            |           |   |                          |        |   |            |        |   |                          |        |   |            |        |
| 3    | Max.Operating Temp.+3/-0                | 30+/-3   |  |   |   |      |            |           |   |                          |        |   |            |        |   |                          |        |   |            |        |
| 4    | Room Temp.                              | 2 to 3   |  |   |   |      |            |           |   |                          |        |   |            |        |   |                          |        |   |            |        |
| 15   | High Temperature High Humidity (Steady) | Appearance<br>Capacitance Change<br>Q or D.F.<br>I.R.                  | No defects or abnormalities.<br>Within +/-0.75pF<br>Q≥ 100+10C/3 C:Nominal Capacitance(pF)<br>More than 500MΩ  | Mounting method<br>Test Temperature<br>Test Humidity<br>Test Time<br>Test Voltage<br>Charge/discharge current<br>Post-treatment | Solder the capacitor on the test substrate<br>40+/-2°C<br>90%RH to 95%RH<br>500+/-12h<br>Rated Voltage<br>50mA max.<br>Non treatment:Let sit for 24+/-2hours at room temperature, then measure.   |      |            |           |   |                          |        |   |            |        |   |                          |        |   |            |        |

■ Specifications and Test Methods

| No | Item       | Specification  | Test Method(Ref. Standard:JIS C 5101 (all parts), IEC60384 (all parts))  |
|----|------------|--|--|
| 16 | Durability | Appearance No defects or abnormalities.<br>Capacitance Change Within +/-0.3pF<br>Q or D.F. $Q \geq 200+10C$ C:Nominal Capacitance(pF)<br>I.R. More than 1000MΩ | Mounting method Solder the capacitor on the test substrate<br>Test Temperature Maximum Operating Temperature +/-3°C<br>Test Time 1000+/-12h<br>Test Voltage 200% of the rated voltage<br>Charge/discharge current 50mA max.<br>Post-treatment Non treatment:Let sit for 24+/-2hours at room temperature, then measure. |

Table A Capacitance Change between at Reference Temp. and at each Temp. (%)

| Char. | -55°C |       | -30°C |       | -10°C |       |
|-------|-------|-------|-------|-------|-------|-------|
|       | Max.  | Min.  | Max.  | Min.  | Max.  | Min.  |
| 5C    | 0.58  | -0.24 | 0.4   | -0.17 | 0.25  | -0.11 |

**Substrate Bending test**

- Test substrate
  - Material JIS C 6484 Copper-clad laminated sheets for PCBs (Glass fabric base, epoxy resin)
  - Thickness 1.6mm
  - Copper Foil Thickness 0.035mm
  - Kind of Solder Sn-3.0Ag-0.5Cu(Lead Free Solder)
- Land Dimension

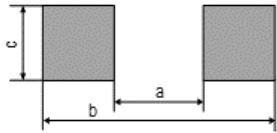


Fig.1

| Type  | Dimension(mm) |     |     |
|-------|---------------|-----|-----|
|       | a             | b   | c   |
| GRM18 | 1.0           | 3.0 | 1.2 |

• Pressurization Method



Fig.2

**Except for Substrate Bending test**

- Test substrate
  - Material JIS C 6484 Copper-clad laminated sheets for PCBs (Glass fabric base, epoxy resin)
  - Thickness 1.6mm or 0.8mm
  - Copper Foil Thickness 0.035mm
  - Kind of Solder Sn-3.0Ag-0.5Cu(Lead Free Solder)
- Land Dimension

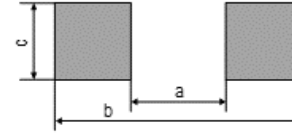


Fig.3

| Type  | Dimension(mm) |     |     |
|-------|---------------|-----|-----|
|       | a             | b   | c   |
| GRM18 | 1.0           | 3.0 | 1.2 |



■ Package (Tape Carrier Packaging)

3. Dimensions of Reel (in mm)



| Reel               | A                 | B              | C               | D               | E           | W         | W1        |
|--------------------|-------------------|----------------|-----------------|-----------------|-------------|-----------|-----------|
| $\phi 180$ mm Reel | $\phi 180+0/-3.0$ | $\phi 50$ min. | $\phi 13+/-0.2$ | $\phi 21+/-0.8$ | $2.0+/-0.5$ | 14.4 max. | $8.4+1.5$ |
| $\phi 330$ mm Reel | $\phi 330+/-2.0$  | $\phi 50$ min. | $\phi 13+/-0.2$ | $\phi 21+/-0.8$ | $2.0+/-0.5$ | 14.4 max. | $8.4+1.5$ |

■ Package (Tape Carrier Packaging)

- Part of the leader and part of the vacant section are attached as follows.  
The sprocket holes are to the right as the tape is pulled toward the user.



- Accumulate tolerance of sprocket holes pitch = +/-0.3mm/10 pitch
- Chip in the tape is enclosed by top tape and bottom tape as shown in 2.Dimensions of Tape.
- The top tape and carrier tape are not attached at the end of the tape for a minimum of 5 pitches.
- There are no jointing for top tape and bottom tape.
- There are no fuzz in the cavity.
- Break down force of top tape : 5N min.  
Break down force of bottom tape : 5N min. (Only a bottom tape existence )
- Reel is made by resin and appeaser and dimension is shown in 3.Dimensions of Reel.  
There are possibly to change the material and dimension due to some impairment.
- Peeling off force : 0.1N to 0.7N in the direction as shown below.

Speed of Peeling off : 300 mm / min



- Label that show the customer parts number, our parts number, our company name, inspection number and quantity, will be put in outside of reel.





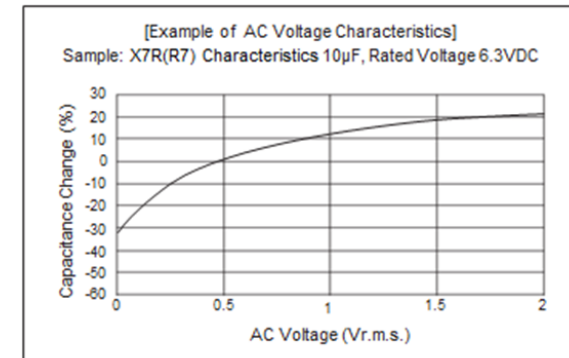
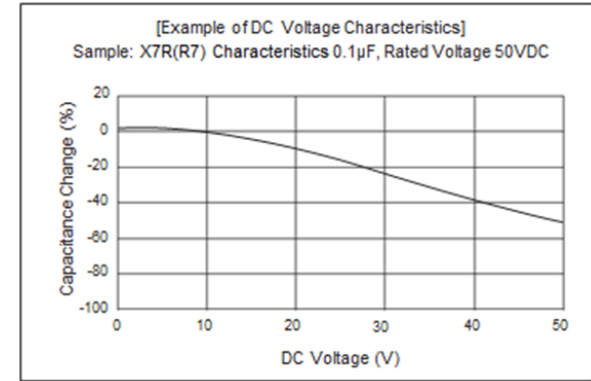
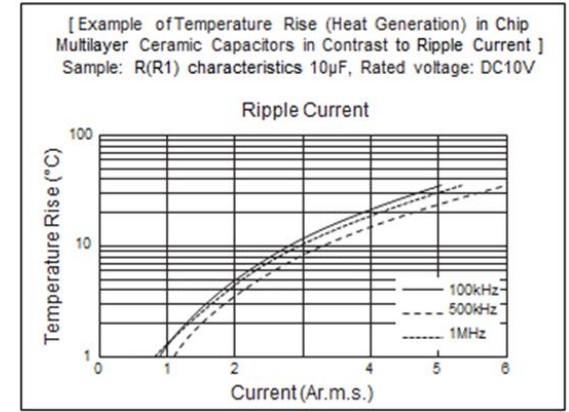
**4. Type of Applied Voltage and Self-heating Temperature**

1. Confirm the operating conditions to make sure that no large current is flowing into the capacitor due to the continuous application of an AC voltage or pulse voltage. When a DC rated voltage product is used in an AC voltage circuit or a pulse voltage circuit, the AC current or pulse current will flow into the capacitor; therefore check the self-heating condition. Please confirm the surface temperature of the capacitor so that the temperature remains within the upper limits of the operating temperature, including the rise in temperature due to self-heating. When the capacitor is used with a high-frequency voltage or pulse voltage, heat may be generated by dielectric loss.

< Applicable to Rated Voltage of less than 100VDC >  
 The load should be contained so that the self-heating of the capacitor body remains below 20°C, when measuring at an ambient temperature of 25°C.

**5. DC Voltage and AC Voltage Characteristic**

1. The capacitance value of a high dielectric constant type capacitor changes depending on the DC voltage applied. Please consider the DC voltage characteristics when a capacitor is selected for use in a DC circuit.
- 1-1. The capacitance of ceramic capacitors may change sharply depending on the applied voltage. (See figure)  
 Please confirm the following in order to secure the capacitance.
- (1) Determine whether the capacitance change caused by the applied voltage is within the allowed range.
  - (2) In the DC voltage characteristics, the rate of capacitance change becomes larger as voltage increases, even if the applied voltage is below the rated voltage. When a high dielectric constant type capacitor is used in a circuit that requires a tight (narrow) capacitance tolerance (e.g., a time constant circuit), please carefully consider the voltage characteristics, and confirm the various characteristics in the actual operating conditions of the system.
2. The capacitance values of high dielectric constant type capacitors changes depending on the AC voltage applied. Please consider the AC voltage characteristics when selecting a capacitor to be used in a AC circuit.



### 6. Capacitance Aging

- 1. The high dielectric constant type capacitors have an Aging characteristic in which the capacitance value decreases with the passage of time. When you use a high dielectric constant type capacitors in a circuit that needs a tight (narrow) capacitance tolerance (e.g., a time-constant circuit), please carefully consider the characteristics of these capacitors, such as their aging, voltage, and temperature characteristics. In addition, check capacitors using your actual appliances at the intended environment and operating conditions.



### 7. Vibration and Shock

- 1. Please confirm the kind of vibration and/or shock, its condition, and any generation of resonance. Please mount the capacitor so as not to generate resonance, and do not allow any impact on the terminals.
- 2. Mechanical shock due to being dropped may cause damage or a crack in the dielectric material of the capacitor. Do not use a dropped capacitor because the quality and reliability may be deteriorated.
- 3. When printed circuit boards are piled up or handled, the corner of another printed circuit board should not be allowed to hit the capacitor in order to avoid a crack or other damage to the capacitor.





**3. Maintenance of the Mounting (pick and place) Machine**

1. Make sure that the following excessive forces are not applied to the capacitors. Check the mounting in the actual device under actual use conditions ahead of time.

1-1. In mounting the capacitors on the printed circuit board, any bending force against them shall be kept to a minimum to prevent them from any damage or cracking.  
Please take into account the following precautions and recommendations for use in your process.

(1) Adjust the lowest position of the pickup nozzle so as not to bend the printed circuit board.



2. Dirt particles and dust accumulated in the suction nozzle and suction mechanism prevent the nozzle from moving smoothly. This creates excessive force on the capacitor during mounting, causing cracked chips.  
Also, the locating claw, when worn out, imposes uneven forces on the chip when positioning, causing cracked chips. The suction nozzle and the locating claw must be maintained, checked and replaced periodically.







**5. Washing**

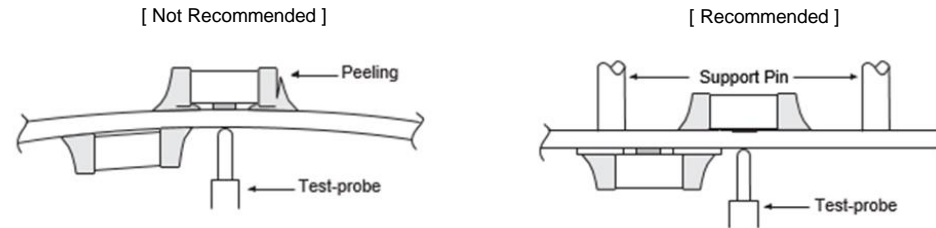
Excessive ultrasonic oscillation during cleaning can cause the PCBs to resonate, resulting in cracked chips or broken solder joints. Before starting your production process, test your cleaning equipment / process to insure it does not degrade the capacitors.

**6. Electrical Test on Printed Circuit Board**

1. Confirm position of the support pin or specific jig, when inspecting the electrical performance of a capacitor after mounting on the printed circuit board.

1-1. Avoid bending the printed circuit board by the pressure of a test-probe, etc. The thrusting force of the test probe can flex the PCB, resulting in cracked chips or open solder joints. Provide support pins on the back side of the PCB to prevent warping or flexing. Install support pins as close to the test-probe as possible.

1-2. Avoid vibration of the board by shock when a test -probe contacts a printed circuit board.

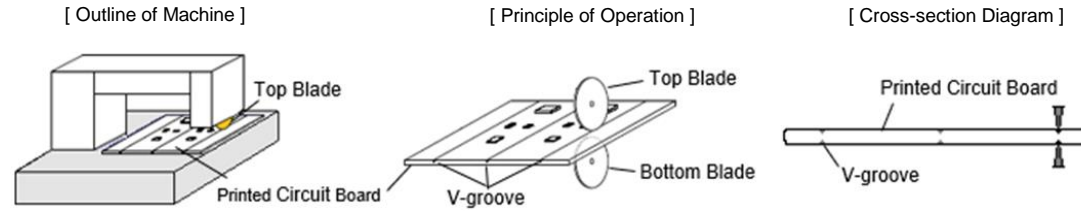




(2) Example of a Disc Separator

An outline of a disc separator is shown as follows. As shown in the Principle of Operation, the top blade and bottom blade are aligned with the V-grooves on the printed circuit board to separate the board. In the following case, board deflection stress will be applied and cause cracks in the capacitors.

- (1) When the adjustment of the top and bottom blades are misaligned, such as deviating in the top-bottom, left-right or front-rear directions
  - (2) The angle of the V groove is too low, depth of the V groove is too shallow, or the V groove is misaligned top-bottom
- If V groove is too deep, it is possible to brake when you handle and carry it. Carefully design depth of the V groove with consideration about strength of material of the printed circuit board.



[ Disc Separator ]

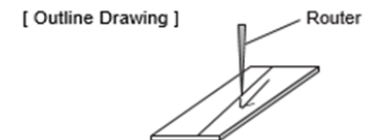
| Recommended   | Not recommended   |   |   |
|---|---|---|---|
|   | Top-bottom Misalignment   | Left-right Misalignment   | Front-rear Misalignment   |
| <p style="text-align: right;">Top Blade</p> <p style="text-align: left;">Bottom Blade</p> | <p style="text-align: right;">Top Blade</p> <p style="text-align: left;">Bottom Blade</p> | <p style="text-align: right;">Top Blade</p> <p style="text-align: left;">Bottom Blade</p> | <p style="text-align: right;">Top Blade</p> <p style="text-align: left;">Bottom Blade</p> |

[ V-groove Design ]

| Example of Recommended V-groove Design | Not Recommended         |           |                   |                |
|--|-------------------------|-----------|-------------------|----------------|
|  | Left-right Misalignment | Low-Angle | Depth too Shallow | Depth too Deep |
|  |                         |           |                   |                |

(3) Example of Router Type Separator

The router type separator performs cutting by a router rotating at a high speed. Since the board does not bend in the cutting process, stress on the board can be suppressed during board separation. When attaching or removing boards to/from the router type separator, carefully handle the boards to prevent bending.







## **2. Under Operation of Equipment**

- 2-1. Do not touch a capacitor directly with bare hands during operation in order to avoid the danger of an electric shock.
- 2-2. Do not allow the terminals of a capacitor to come in contact with any conductive objects (short-circuit).  
Do not expose a capacitor to a conductive liquid, inducing any acid or alkali solutions.
- 2-3. Confirm the environment in which the equipment will operate is under the specified conditions.  
Do not use the equipment under the following environments.
- (1) Being spattered with water or oil.
  - (2) Being exposed to direct sunlight.
  - (3) Being exposed to ozone, ultraviolet rays, or radiation.
  - (4) Being exposed to toxic gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas etc.)
  - (5) Any vibrations or mechanical shocks exceeding the specified limits.
  - (6) Moisture condensing environments.
- 2-4. Use damp proof countermeasures if using under any conditions that can cause condensation.

## **3. Others**

### 3-1. In an Emergency

- (1) If the equipment should generate smoke, fire, or smell, immediately turn off or unplug the equipment. If the equipment is not turned off or unplugged, the hazards may be worsened by supplying continuous power.
- (2) In this type of situation, do not allow face and hands to come in contact with the capacitor or burns may be caused by the capacitor's high temperature.

### 3-2. Disposal of waste

When capacitors are disposed of, they must be burned or buried by an industrial waste vendor with the appropriate licenses.

### 3-3. Circuit Design

#### (1) Addition of Fail Safe Function

Capacitors that are cracked by dropping or bending of the board may cause deterioration of the insulation resistance, and result in a short.

If the circuit being used may cause an electrical shock, smoke or fire when a capacitor is shorted, be sure to install fail-safe functions, such as a fuse, to prevent secondary accidents.

#### (2) This series are not safety standard certified products.

### 3-4. Remarks

Failure to follow the cautions may result, worst case, in a short circuit and smoking when the product is used.

The above notices are for standard applications and conditions. Contact us when the products are used in special mounting conditions.

Select optimum conditions for operation as they determine the reliability of the product after assembly.

The data herein are given in typical values, not guaranteed ratings.

## Notice

### ■ Rating

#### 1. Operating Temperature

1. The operating temperature limit depends on the capacitor.
  - 1-1. Do not apply temperatures exceeding the maximum operating temperature.  
It is necessary to select a capacitor with a suitable rated temperature that will cover the operating temperature range.  
It is also necessary to consider the temperature distribution in equipment and the seasonal temperature variable factor.
  - 1-2. Consider the self-heating factor of the capacitor  
The surface temperature of the capacitor shall not exceed the maximum operating temperature including self-heating.

#### 2. Atmosphere Surroundings (gaseous and liquid)

1. Restriction on the operating environment of capacitors.
  - 1-1. The capacitor will short-circuit by water or brine. It may shorten the lifetime and may have the failure by the corrosion of terminals and the permeation of moisture into capacitor.
  - 1-2. The same phenomenon as the above may occur when the electrodes or terminals of the capacitor are subject to moisture condensation.
  - 1-3. The deterioration of characteristics and insulation resistance due to the oxidization or corrosion of terminal electrodes may result in breakdown when the capacitor is exposed to corrosive or volatile gases or solvents for long periods of time.

#### 3. Piezo-electric Phenomenon

1. When using high dielectric constant type capacitors in AC or pulse circuits, the capacitor itself vibrates at specific frequencies and noise may be generated. Moreover, when the mechanical vibration or shock is added to capacitor, noise may occur.

■ Soldering and Mounting

1. PCB Design

1. Notice for Pattern Forms

- 1-1. Unlike leaded components, chip components are susceptible to flexing stresses since they are mounted directly on the substrate. They are also more sensitive to mechanical and thermal stresses than leaded components. Excess solder fillet height can multiply these stresses and cause chip cracking. When designing substrates, take land patterns and dimensions into consideration to eliminate the possibility of excess solder fillet height.
- 1-2. There is a possibility of chip cracking caused by PCB expansion/contraction with heat, because stress on a chip is different depending on PCB material and structure. When the thermal expansion coefficient greatly differs between the board used for mounting and the chip, it will cause cracking of the chip due to the thermal expansion and contraction. When capacitors are mounted on a fluorine resin printed circuit board or on a single-layered glass epoxy board, it may also cause cracking of the chip for the same reason.
- 1-3. If you are replacing by smaller capacitors, you should not only consider the Land size change but also consider changing the Wiring Width, Wiring direction, and copper foil thickness because the risk of chip cracking is increased with just a Land size change.

Pattern Forms

| Item  | Prohibited | Correct |
|---|------------|---------|
| Placing Close to Chassis                          |            |         |
| Placing of Chip Components and Leaded Components  |            |         |
| Placing of Leaded Components after Chip Component |            |         |
| Lateral Mounting                                  |            |         |



3. Board Design

When designing the board, keep in mind that the amount of strain which occurs will increase depending on the size and material of the board.

Relationship with amount of strain to the board thickness, length, width, etc.]

$$\epsilon = \frac{3PL}{2Ewh^2}$$

Relationship between load and strain



$\epsilon$  : Strain on center of board ( $\mu\text{st}$ )  
 $L$  : Distance between supporting points (mm)  
 $w$  : Board width (mm)  
 $h$  : Board thickness (mm)  
 $E$  : Elastic modulus of board ( $\text{N/m}^2=\text{Pa}$ )  
 $Y$  : Deflection (mm)  
 $P$  : Load (N)

When the load is constant, the following relationship can be established.

- As the distance between the supporting points (L) increases, the amount of strain also increases.  
 → Reduce the distance between the supporting points.
- As the elastic modulus (E) decreases, the amount of strain increases.  
 → Increase the elastic modulus.
- As the board width (w) decreases, the amount of strain increases.  
 → Increase the width of the board.
- As the board thickness (h) decreases, the amount of strain increases.  
 → Increase the thickness of the board.

Since the board thickness is squared, the effect on the amount of strain becomes even greater.



### **3. Reflow soldering**

The flux in the solder paste contains halogen-based substances and organic acids as activators. Strong acidic flux can corrode the capacitor and degrade its performance. Please check the quality of capacitor after mounting.

### **4. Washing**

1. Please evaluate the capacitor using actual cleaning equipment and conditions to confirm the quality, and select the solvent for cleaning.
2. Unsuitable cleaning may leave residual flux or other foreign substances, causing deterioration of electrical characteristics and the reliability of the capacitors.

### **5. Coating**

1. A crack may be caused in the capacitor due to the stress of the thermal contraction of the resin during curing process.  
The stress is affected by the amount of resin and curing contraction. Select a resin with low curing contraction.  
The difference in the thermal expansion coefficient between a coating resin or a molding resin and the capacitor may cause the destruction and deterioration of the capacitor such as a crack or peeling, and lead to the deterioration of insulation resistance or dielectric breakdown.  
Select a resin for which the thermal expansion coefficient is as close to that of the capacitor as possible. A silicone resin can be used as an under-coating to buffer against the stress.
2. Select a resin that is less hygroscopic.  
Using hygroscopic resins under high humidity conditions may cause the deterioration of the insulation resistance of a capacitor. An epoxy resin can be used as a less hygroscopic resin.
3. The halogen system substance and organic acid are included in coating material, and a chip corrodes by the kind of Coating material. Do not use strong acid type.

## ■ Others

### 1. Transportation

1. The performance of a capacitor may be affected by the conditions during transportation.

1-1. The capacitors shall be protected against excessive temperature, humidity and mechanical force during transportation.

- Mechanical condition

Transportation shall be done in such a way that the boxes are not deformed and forces are not directly passed on to the inner packaging.

1-2. Do not apply excessive vibration, shock, or pressure to the capacitor.

(1) When excessive mechanical shock or pressure is applied to a capacitor, chipping or cracking may occur in the ceramic body of the capacitor.

(2) When the sharp edge of an air driver, a soldering iron, tweezers, a chassis, etc. impacts strongly on the surface of the capacitor, the capacitor may crack and short-circuit.

1-3. Do not use a capacitor to which excessive shock was applied by dropping etc. A capacitor dropped accidentally during processing may be damaged.

### 2. Characteristics Evaluation in the Actual System

1. Evaluate the capacitor in the actual system, to confirm that there is no problem with the performance and specification values in a finished product before using.

2. Since a voltage dependency and temperature dependency exists in the capacitance of high dielectric type ceramic capacitors, the capacitance may change depending on the operating conditions in the actual system. Therefore, be sure to evaluate the various characteristics, such as the leakage current and noise absorptivity, which will affect the capacitance value of the capacitor.

3. In addition, voltages exceeding the predetermined surge may be applied to the capacitor by the inductance in the actual system. Evaluate the surge resistance in the actual system as required.

**NOTE**

1. Please make sure that your product has been evaluated in view of your specifications with our product being mounted to your product.
2. You are requested not to use our product deviating from this product specification.
3. We consider it not appropriate to include any terms and conditions with regard to the business transaction in the product specifications, drawings or other technical documents.  
Therefore, if your technical documents as above include such terms and conditions such as warranty clause, product liability clause, or intellectual property infringement liability clause, they will be deemed to be invalid.